Characterization of contact properties at interface between metal and graphene up to 15 GHz.

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Abstract

The contact properties between metal and monolayer chemical vapor deposition (CVD) graphene were investigated, and coplanar waveguides (CPWs) composed of CVD graphene-based signal lines and Au-based ground lines were fabricated. The reflection coefficients of the CPWs were experimentally measured from 1 to 15 GHz. The contact properties were represented using the equivalent circuit model, which consists of paralell contact resistance R_c and paralell contact capacitance C_c . The calculated reflection coefficients of the model nearly agreed with the measured ones, which indicated that this model is suitable for analyzing the contact properties between metal and graphene up to 15 GHz. Bacause the impedance of C_c ($|1/(\omega C_c)| = 4.8 \times 10^{-3} \Omega$) is four orders of magnitude lower than that of R_c (50 Ω) at 15 GHz, the current flow is more capacitive and efficient than that in the DC band. The ratio of power consumption and power storage in the microwave band to the total power consumption in the DC band decreased with increasing frequency and increasing C_c . Therefore, higher C_c is preferable in designing microwave devices with a metal/graphene-based feeding structure, such as antennas and transmission lines.

Title pageTitle : "Characterization of contact properties at interface between metal and graphene up to 15 GHz." **Author's names and affiliations :**Shohei Kosuga^{1, 2}, Ryosuke Suga¹, Takeshi Watanabe¹, Osamu Hashimoto¹, and Shinji Koh¹

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- Abstract The contact properties between metal and monolayer chemical vapor deposition (CVD) graphene were investigated, and coplanar waveguides (CPWs) composed of CVD graphene-based signal lines and Au-based ground lines were fabricated. The reflection coefficients of the CPWs were experimentally measured from 1 to 15 GHz. The contact properties were represented using the equivalent circuit model, which consists of paralell contact resistance R_c and paralell contact capacitance C_c . The calculated reflection coefficients of the model nearly agreed with the measured ones, which indicated that this model is suitable for analyzing the contact properties between metal and graphene up to 15 GHz. Bacause the impedance of $C_c(|\frac{1}{\omega C_c}| = 4.8 \times 10^{-3} \Omega)$ is four orders of magnitude lower than that of $R_c(50 \ \Omega)$ at 15 GHz, the current flow is more capacitive and efficient than that in the DC band. The ratio of power consumption and power storage in the microwave band to the total power consumption in the DC band decreased with increasing frequency and increasing C_c . Therefore, higher C_c is preferable in designing microwave devices with a metal/graphene-based feeding structure, such as antennas and transmission lines. Keywords :graphene, contact properties, coplanar waveguide, microwave, optically transparent antennas
- Text

Introduction

Optically transparent antennas have attracted much attention because they can be located in various places without altering the landscape. Such antennas are fabricated using transparent conductive materials, such as indium tin oxide (ITO) [1], gallium-doped zinc oxide (GZO) [2], indium zinc tin oxide (IZTO) [3], and metal mesh structures [4]. We focused on graphene as an electrode material for optically transparent antennas. The high carrier mobility [5], optical transparency [6],and flexibility [7] make graphene attractive as an electrode material for optically transparent antennas. We previously reported that an invisible dipole antenna fabricated using monolayer chemical vapor deposition (CVD) graphene radiates microwaves in the microwave band [8] [9]. The optical transparency of the fabricated graphene antenna was about 97.7%. Optically transparent antennas fabricated using 6-layer-stacked CVD graphene with a sheet resistance of 18 Ω/sq and optical transparency of 85% has recently been reported [10]. Optically transparent microwave absorbers based on graphene [11] [12] and printed graphene-based antennas [13] [14], which are opaque to visible light, have also been reported.

The electrical contact properties at the interface between the metal-based feeding lines and graphene-based optically transparent antennas are important to obtain high radiation efficiency. The metal/graphene contact structure is the most commonly used to feed the microwave power to graphene-based antennas. In the DC band, the contact resistance at the interface between metal and graphene may significantly limit the performance of graphene-based deveices because the current injection from metal to graphene is suppressed due to the small density of states in graphene [15]. The graphene-based invisible antenna investigated in our previous studies [8] [9] consists of dipole elements fabricated using graphene as a half-wavelength dipole antenna and a coplanar waveguide (CPW) fabricated using Au and graphene as a feeding line. CPWs are favoarable structures for feeding graphene-based antennas because all electrodes of CPWs can be integrated on the surface side of the substrates, which are compatible with the transfer techniques of graphene and photolithography techniques. The transmission properties of CPWs fabricated with metal and graphene have been reported [16]. In the microwave band, the contact properties between metal and graphene are represented by the parallel contact resistance R_c and parallel contact capacitance C_c [17]. However, the properties of the metal/graphene contact in the microwave band have not been discussed and not been optimized in detail, though they are quite important to optimize the performance of the graphene-based antennas.

We focused on the properties of the metal/graphene contact in the microwave band and fabricated CPWs composed of Au electrodes and monolayer CVD graphene. To characterize the properties of the metal/graphene contact, the equivalent circuit model of the fabricated CPWs was used for the analyzing the contact properties from 1 to 15 GHz, in which the metal/graphene contact and the graphene area are represented by lumped components, which were experimentary determined. The calculated reflection coefficients for the equivalent circuit model were compared with the measured ones. Finally, we compared the impedance of C_c and R_c .

1. Experiments

2. Fabrication and measurement set up

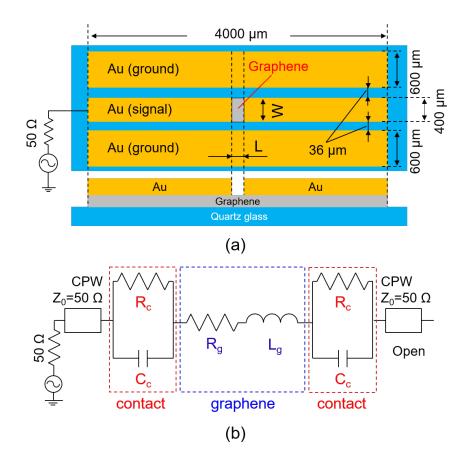


Figure 1 (a) shows the structure of one of the CPWs fabricated using monolayer CVD graphene and Au on a quartz glass substrate. Note that the graphene layers lie underneath all areas of the Au layers. In the area of monolayer CVD graphene, the width of the graphene lines W was fixed 400 µm and the lengthes of the graphene lines L were set to 10, 30, and 50 µm. The characteristic impedance of an Au CPW is 50 Ω and the length of the CPW is 4000 µm. The signal line width is 400 µm and the gap between the signal line and ground is 36 µm. Graphene layers were grown on Cu foils by low-pressure CVD and transferred onto the quartz glass substrate. A CPW composed of graphene and Au was fabricated by electron beam evaporation and standard photolithography. The detailed fabrication procedure of the CPWs were reported in a previous paper [8].

The reflection coefficients of the fabricated CPWs were measured from 1 to 15 GHz using a ground-signalground microwave probe on a wafer-probe station and a vector network analyzer. One port of the vector network analyzer was connected to one of the fabricated CPW. The terminal of the fabricated CPW was an electrical open. The measured reflection coefficients will be shown and discussed later.

Equivalent circuit of the fabricated CPWs

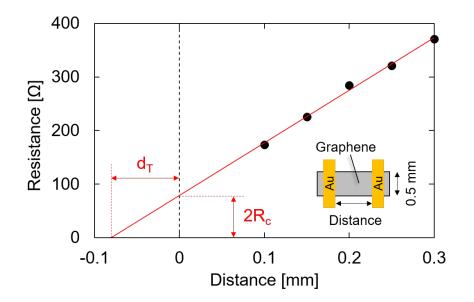
The contact characteristics of the metal/graphene contact were analyzed using the equivalent circuit model shown in Figure 1 (b). There are three components to this model: an Au-based CPW with characteristic impedance, contact impedance, and impedance of the graphene line. The contact impedance is represented by R_c and C_c . We assumed that the characteristic impedance of the CPW fabricated using Au/graphene is 50 Ω because the contribution of the graphene underneath the Au layers is negligible and that C_c is represented by the quantum capacitance C_q of graphene [18]. The graphene line impedance is represented by the series resistance R_q and series inductance L_q of the graphene line [17]: L_q is the kinetic inductance of the graphene line. It was assumed that the graphene impedance and contact impedance can be represented by lumped circuit components because L is much smaller than the electrical length from 1 to 15 GHz.

1. Characterization for contact properties

2. Evaluation of impedance of graphene line and contact impedance

To quantitavely characterize R_g , we processed the monolayer CVD graphene film into a Hall bar device of a van der Pauw geometry placed on a quartz glass substrate. Hall measurements provided electrical properties, such as the sheet resistance, carrier mobillity, and carrier density of the graphene film, which are not affected by the contact resistance [19]. The measured sheet resistance, carrier mobillity, and sheet carrier density of the monolayer CVD graphene are 750 Ω/sq , 1,320 cm²/Vs and 6.4×10^{12} cm⁻², respectively. The Hall coefficient is postive (+98 m²/C), inidicating that the charge carriers in the graphene chanel are holes. According to the measured sheet resistance of the monolayer CVD graphene, the R_g for the graphene lines of L = 10, 30, and 50 µm in the CPWs can be calculated to as 19, 56, and 93 Ω , respectively.

The sheet impedance of graphene, $Z_s \Omega/sq$, can be expressed as $Z_{sq} = R_{sq} + j\omega L_{sq}$, where R_{sq} and L_{sq} are the sheet resistance and sheet inductance of graphene, respectively. It should be noted that the units of R_{sq} and L_{sq} are defined as Ω/sq and H/sq (= $\Omega s/sq$). Jeon et al. reported that L_{sq} can be expressed as $L_{sq} = \tau P_{sq}$, where τ is the transport relaxation time, which was assumed to be 1 ps in a previous report [17]. We also assume that τ is 1 ps and R_{sq} is determined to be 750 Ω/sq in the Hall measurement. Thus, L_{sq} in the graphene line in this study was estimated to be about 0.75 nH/sq. Therefore, the L_g for the graphene lines of L = 10, 30, and 50 µm in the CPWs can be calculated as 0.019, 0.056, and 0.093 nH, respectively.



The R_c was experimentally determined from the transfer length method (TLM) test using the TLM device structure shown in the inset of Figure 2. The TLM device consists of a monolayer CVD graphene strip and Au electrodes. The width of the graphene strip was fixed to 0.5 mm, and the distances between the two adjescent Au electrodes were set to 0.1, 0.15, 0.2, 0.25, and 0.3 mm. The contact area between the graphene strip and Au electrodes were set to $0.1 \times 0.5 \text{ mm}^2$. In Figure 2, the measured resistance, including the channel resistance and contact resistances, of the graphene strip are plotted as a function of the length of the graphene strip, and the red line is the linear fitting line. For zero distance, the channel resistance vanished and the intersection point of the resistance axis corresponded to the contact resistances $2R_c$ ($\tilde{}$ 80 Ω). Thus, the contact resistance in the TLM device was estimated to be 40 Ω . The contact resistivity depends on the contact width between the graphene and electrodes; hence, it can be calculated as 20 Ω mm.

The C_c was estimated considering the transfer area S_T [cm²] underneath the Au layer and the quantum capacitance per unit area C_q nF/cm² of the monolayer CVD graphene in the CPW. The C_c can be expressed as $C_c = C_q \times S_T$ nF. At the interface between Au and graphene, current crowding takes place in the effective $S_T = d_T \times W$, where d_T is the transfer length at the interface between Au and graphene. The d_T , which can be determined as the interseption point of the distance axis in Figure 2, was ~80 µm [19]. Since W was fixed to 400 µm, S_T can be calculated as 3.2×10^{-4} cm². Nagashio et al. reported that the C_q of graphene is proportional to the Fermi energy of graphene [18] and can be expressed as

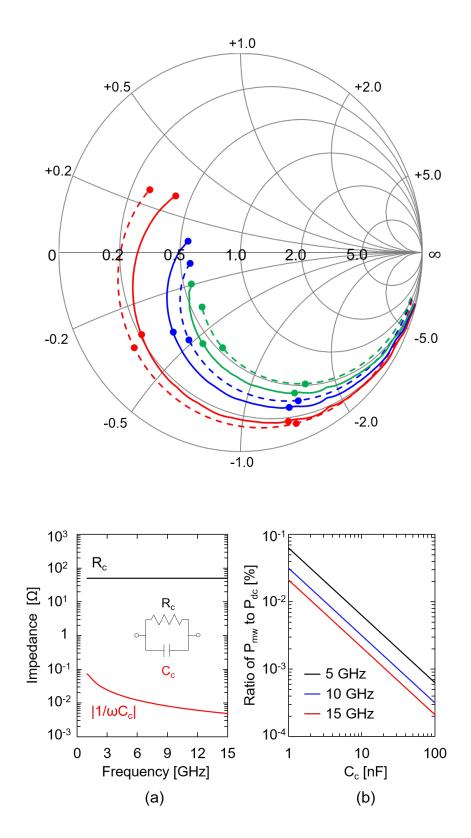
$$C_q = \frac{2e^2 E_F}{\pi \left(v_F \hbar\right)^2},$$

where E_F is the Fermi energy, v_F is the Fermi verocity $(1 \times 10^8 \text{ cm/s})$ and \hbar is Plank's constant. The E_F are given by

$$E_F = \hbar v_F \sqrt{\frac{n\pi}{\lambda}},$$

where n is the carrier density of graphene and λ is the fitting parameter, which is generally set to 1.1 [20]. Since the measured sheet carrier density of the monolayer CVD graphene is 6.4×10^{12} cm⁻², the E_f of the monolayer CVD graphene can be calculated as ~0.28 eV. Therefore, the C_q of graphene can be estimated from the above equation to be $6.7 \,\mu\text{F/cm}^2$. Consequently, C_c can be calculated as 2.2 nF using $C_c = C_q \times S_T$.

Discussion on contact impedance



The R_g , L_g , R_c , and C_c , which were determined in the previous section, are listed in Table I. The reflection coefficients for the equivalent circuit model were calculated using these parameters. Figure 3 shows the measured (solid lines) and calculated (dashed lines) reflection coefficients of the CPWs from 1 to 15 GHz on a smith chart. The red, blue, and green lines correspond to the data of the reflection coefficients for CPWs with the graphene lines of L = 10, 30, and 50 µm. The points in Figure 3 are the measured and calculated reflection coefficients at 5, 10, and 15 GHz. As shown in Figure 3, the reflection coefficients depended on L. The calculated reflection coefficients for this model nearly agreed with the measured ones from 1 to 15 GHz. Therefore, this model can be applied for the analyzing the contact properties between metal and graphene up to 15 GHz. The phase angle of the reflection coefficients for the graphene lines of $L = 50 \ \mu m$ was smaller than that for graphene lines of $L = 10 \ \mu m$. We previously reported that the phase constant $\beta \ (\approx \frac{1}{2}\omega\mu_0\sigma) \ deg/mmof$ graphene is smaller than that of metal due to the lower conductivity of graphene [9]. Therefore, the β of the graphene line decreases with increasing L. Consequently, the contact impedance was correctly characterized by R_c and C_c obtained from the TLM, Hall measurement, and estimation, as shown in Table I.

We presented the contact impedance at the interface between a metal and graphene from 1 to 15 GHz. As mention the above, R_c and C_c were 50 Ω and 2.2 nF, respectively. In Figure 4 (a), the impedance of C_c is plotted as a function of frequency. It should be that the the impedance of C_c is represented as $\left|\frac{1}{\omega C_c}\right|$ and is more than two orders of magnitude lower than that of R_c from 1 to 15 GHz. It also should be noted that the contact impedance consists of R_c and C_c . Therefore, these results indicate that the current flows mainly not through R_c , but through C_c in the microwave band. In the DC band, houwever, most of the current flows through R_c because the impedance value of C_c is approximately infinite. Therefore, it is suggested that the current flow from a metal into graphene in the microwave band is more capacitive and efficient than that in the DC band. In Figure 4 (b), the ratio of power consumption and power storage in the microwave band P_{mw} , to the total power consumption in the DC band P_{dc} , which represents the degree of energy dissipation at the metal/graphene contact, is plotted as a function of C_c . The P_{mw} / P_{dc} ratio is expressed as $\frac{P_{mw}}{P_{dc}} = \frac{\left|\frac{1}{\omega C_c}\right|}{R_c + \left|\frac{1}{\omega C_c}\right|} \times 100 \,[\%]$. The black, blue, and red lines correspond to the P_{mw} / P_{dc} ratio for 5, 10, and 15 GHz, respectively. The P_{mw} / P_{dc} ratio decreased with increasing frequency and increasing C_c . Therefore, in the microwave band, C_c is a critical factor, hence, a reduction in the impedance of C_c should be achieved for more efficient carrier injection from metal to graphene. These results indicate that a higher C_c is preferred in designing the feeding structure of graphene-based microwave devices such as antennas and transmission lines. For example, a larger contact area leads to a higher C_c because of increasing S_T . Furthermore, increasing the n of graphene may provide a higher C_c because it is represented by C_q of graphene, which is proportional ton.

Conclusions

The contact properties at the interface between metal and graphene in the microwave band from 1 to 15 GHz were analyzed through experimental measurements and caluculation with an equivalent circuit model using lumped circuit components. The calculated reflection coefficients based on the lumped circuit components nearly agreed with the measured ones, which indicated that the equivalent circuit model can be applied to analyze the contact properties between metal and graphene up to 15 GHz. The impedance of C_c was more than two orders of magnitude lower than that of R_c . This indicates that most of the carrier injection from metal to graphene flows not through R_c but through C_c in the microwave band, which suggests that the current flow between metal and graphene in the microwave band is more capacitive and efficient than that in the DC band. Therefore, the interface between metal and graphene with high capacitance is preferred in designing the feeding structure of graphene-based microwave devices. This work provides a building block that is essential for designing optically transparent graphene-based antennas.

• Figure legendsFigure 1: (a) Bird's eye and cross-sectional views and (b) equivalent circuit model of fabricated CPWs. Figure 2: Measured resistance extracted with TLM. Inset is schematic structure of TLM device. Figure 3: Measured (solid) and calculated (dashed) reflection coefficients with graphene lines of L = 10 (red), 30 (blue), and 50 µm (green) on smith chart. Points on graph are reflection

coefficients at 5, 10, and 15 GHz. Figure 4: (a) Impedance of parallel contact resistance R_c . and contact capacitance C_c . (b) Ratio of power consumption and power storage in microwave band P_{mw} to total power consumption in DC band P_{dc} for 5 (black), 10 (blue), and 15 GHz (red). Table I: Measured and estimated parameters of CPWs.

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- Conflict of Interests Authors have no conflict of interest relevant to this article.
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